

FLUKE®

Fluke 115 Multimeter

Technical Data



Compact true-rms meter for field service technicians

The Fluke 115 is the solution for a wide variety of electrical and electronic testing applications. This true-rms meter provides easy one-handed operation in a compact package.

Features include:

- Resistance, continuity, frequency, capacitance, and diode test
- Measures 20 A (30 seconds momentary; 10 A continuous)
- Large white LED backlight to work in poorly lit areas
- Compact ergonomic design for one-handed operation
- Compatible with optional magnetic hanger (ToolPak™)
- True-rms for accurate measurements on non-linear loads
- Min/Max/Average with elapsed time to record signal fluctuations
- CAT III 600 V safety rated

General specifications

Accuracy is specified for 1 year after calibration, at operating temperatures of 18 °C to 28 °C, with relative humidity at 0 % to 95 %.

The accuracy specifications take the form of:
 $\pm ([\% \text{ of reading}] + [\text{counts}])$

Maximum voltage between any terminal and earth ground	600 V
Surge protection	6 kV peak per IEC 61010-1 600 V CAT III, Pollution Degree 2
Fuse for A input	11 A, 1000 V FAST Fuse (Fluke PN 803293)
Display	Digital: 6,000 counts, updates 4/sec
Bar graph	33 segments, updates 32/sec
Operating temperature	-10 °C to + 50 °C
Storage temperature	-40 °C to + 60 °C
Battery	9 volt Alkaline, NEDA 1604A/ IEC 6LR61
Battery life	400 hours typical, without backlight

Actual size



Accuracy specifications

Measurement	Range	Resolution	Accuracy ± ([% of reading] + [counts])
DC millivolts	600.0 mV	0.1 mV	2.0 % + 3
DC volts	6.000 V	0.001 V	
	60.00 V	0.01 V	
	600.0 V	0.1 V	
Auto volts	600.0 V	0.1 V	2.0 % + 3 (dc, 45 Hz to 500 Hz) 4.0 % + 3 (500 Hz to 1 kHz)
AC millivolts ¹ true-rms	600.0 mV	0.1 mV	1.0 % + 3 (dc, 45 Hz to 500 Hz) 2.0 % + 3 (500 Hz to 1 kHz)
AC volts ¹ true-rms	6.000 V	0.001 V	1.0 % + 3 (45 Hz to 500 Hz) 2.0 % + 3 (500 Hz to 1 kHz)
	60.00 V	0.01 V	
	600.0 V	0.1 V	
Continuity	600 Ω	1 Ω	Beeper on < 20 Ω off > 250 Ω; detects opens or shorts of 500 μs or longer.
Ohms	600.0 Ω	0.1 Ω	0.9 % + 2
	6.000 kΩ	0.001 kΩ	0.9 % + 1
	60.00 kΩ	0.01 kΩ	
	600.0 kΩ	0.1 kΩ	
	6.000 MΩ	0.001 MΩ	
	40.00 MΩ	0.01 MΩ	1.5 % + 2
Diode test	2.000 V	0.001 V	0.9 % + 2
Capacitance	1000 nF	1 nF	1.9 % + 2
	10.00 μF	0.01 μF	
	100.0 μF	0.1 μF	
	9999 μF	1 μF	1.9 % + 2
	100 μF to 1000 μF		
	> 1000 μF		
Lo-Z capacitance	1 nF to 500 μF		10 % + 2 typical
AC amps true-rms (45 Hz to 500 Hz)	6.000 A	0.001 A	1.5 % + 3
	10.00 A	0.01 A	
	20 A continuous overload for 30 seconds max.		
DC amps	6.000 A	0.001 A	1.0 % + 3
	10.00 A	0.01 A	
	20 A continuous overload for 30 seconds max.		
Hz (V or A input) ²	99.99 Hz	0.01 Hz	0.1 % + 2
	999.9 Hz	0.1 Hz	
	9.999 kHz	0.001 kHz	
	50.00 kHz	0.01 kHz	

Notes:

¹ All ac voltage ranges are specified from 1 % to 100 % of range. Because inputs below 1 % of range are not specified, it is normal for this and other true-rms meters to display non-zero readings when the test leads are disconnected from a circuit or are shorted together. For volts, crest factor of ≤ 3 at 4000 counts, decreasing linearly to 1.5 at full scale. AC volts is ac coupled and ac mV is dc coupled.

² Frequency is ac coupled, 5 Hz to 50 kHz for ac voltage. Frequency is dc coupled, 45 Hz to 5 kHz for ac current.

Ordering information

Fluke-115 Multimeter

Included

TL75 Test leads, holster, User's manual and 9 V battery (installed).



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